

SBOS193 - MARCH 2001

High-Side, Bidirectional CURRENT SHUNT MONITOR

FEATURES

- COMPLETE BIDIRECTIONAL CURRENT MEASUREMENT CIRCUIT
- WIDE SUPPLY RANGE: 2.7V to 40V
- SUPPLY-INDEPENDENT COMMON-MODE VOLTAGE: 2.7V TO 60V
- RESISTOR PROGRAMMABLE GAIN SET
- LOW QUIESCENT CURRENT: 75µA (typ)
- MSOP-8 PACKAGE

APPLICATIONS

- CURRENT SHUNT MEASUREMENT: Automotive, Telephone, Computers, Power Systems, Test, General Instrumentation
- PORTABLE & BATTERY-BACKUP SYSTEMS
- **BATTERY CHARGERS**
- POWER MANAGEMENT
- CELL PHONES

DESCRIPTION

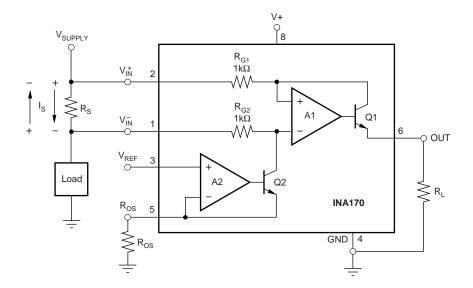
The INA170 is a high-side, bidirectional current shunt monitor featuring a wide input common-mode voltage range, low quiescent current, and a tiny MSOP-8 package.

Bidirectional current measurement is accomplished by output offsetting. The offset voltage level is set with an external resistor and voltage reference. This permits measurement of a bidirectional shunt current while using a single supply for the INA170.

Input common-mode and power-supply voltages are independent. Input voltage can range from +2.7V to +60V on any supply voltage from +2.7V to +40V. Low 10µA input bias current adds minimal error to the shunt current.

The INA170 converts a differential input voltage to a current output. This current develops a voltage across an external load resistor, setting any gain from 1 to over 100.

The INA170 is available in an MSOP-8 package, and is specified over the extended industrial temperature range, -40° C to $+85^{\circ}$ C with operation from -55° C to $+125^{\circ}$ C.





Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



PACKAGE/ORDERING INFORMATION

PRODUCT	PACKAGE	PACKAGE DRAWING NUMBER	SPECIFIED TEMPERATURE RANGE	PACKAGE MARKING	ORDERING NUMBER ⁽¹⁾	TRANSPORT MEDIA
INA170EA	MSOP-8	337 "	–40°C to +85°C	INA170EA INA170EA/250 INA170EA/2K5		Tape and Reel Tape and Reel

NOTE: (1) Models with a slash (/) are available only in Tape and Reel in the quantities indicated (e.g., /2K5 indicates 2500 devices per reel). Ordering 2500 pieces of "INA170NA/2K5" will get a single 2500-piece Tape and Reel.

ABSOLUTE MAXIMUM RATINGS(1)

Supply Voltage, V+ to GND	0.3V to 40V			
Analog Inputs, Common Mode	0.3V to 60V			
Differential $(V_{IN}^+) - (V_{IN}^-)$	40V to 2V			
Analog Output, Out	0.3V to 40V			
Operating Temperature	55°C to +125°C			
Storage Temperature	65°C to +150°C			
Junction Temperature	+150°C			
Lead Temperature (soldering, 10s)	+300°C			

NOTE: (1) Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not implied.



ELECTROSTATIC DISCHARGE SENSITIVITY

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.



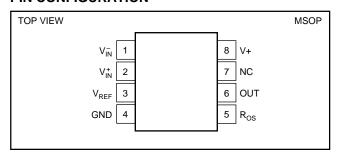
ELECTRICAL CHARACTERISTICS

At T_A = -40°C to +85°C, V_S = 5V, V_{\text{IN}}^+ = 12V, R_OUT = 25k Ω , unless otherwise noted.

		INA170EA			
PARAMETER	CONDITION	MIN TYP		MAX	UNITS
INPUT Full-Scale Sense (Input) Voltage Common-Mode Input Range Common-Mode Rejection Offset Voltage ⁽¹⁾ RTI vs Temperature vs Power Supply Input Bias Current	$V_{SENSE} = V_{lN}^{+} - V_{lN}^{-}$ $V_{lN}^{+} = +2.7V \text{ to } +60V, V_{SENSE} = 50\text{mV}$ $T_{MIN} \text{ to } T_{MAX}^{-}$ $V_{lN}^{+} = +2.7V \text{ to } +60V, V_{SENSE} = 50\text{mV}$ V_{lN}^{+}, V_{lN}^{-}	+2.7 100	100 120 ±0.2 1 0.1 10	500 +60 ±1 10	mV V dB mV μV/°C μV/V uA
OFFSETTING AMPLIFIER Offsetting Equation Input Voltage Input Offset Voltage vs Temperature Programming Current through Ros Input Impedance Input Bias Current	$V_{OS} = (R_L/R_{OS}) V_{REF}$ $T_{MIN} \text{ to } T_{MAX}$ V_{IN}^+, V_{IN}^-	0	±0.2 10 10 ¹⁰ 4 +10	V _S – 1 ±1 1	V mV μV/°C mA Ω pF nA
OUTPUT Transconductance vs Temperature Nonlinearity Error Total Output Error Output Impedance Voltage Output Swing to Power Supply, V+ Swing to Common Mode, V _{CM}	$V_{SENSE} = 10$ mV to 150mV $V_{SENSE} = 100$ mV $V_{SENSE} = 10$ mV to 150mV $V_{SENSE} = 100$ mV	0.990	1 50 ±0.01 ±0.5 1 5 (V+) - 0.9 V _{CM} - 0.6	1.01 ±0.1 ±2 (V+) - 1.2 V _{CM} - 1.0	mA/V nA/°C % GΩ pF V
FREQUENCY RESPONSE Bandwidth Settling Time (0.1%)	$R_{OUT} = 10kΩ$ 5V Step, $R_{OUT} = 10kΩ$		400 3		kHz μs
NOISE Output-Current Noise Density Total Output-Current Noise	BW = 100kHz		20 7		pA/√Hz nA RMS
POWER SUPPLY Operating Range Quiescent Current	V+ V _{SENSE} = 0, I _O = 0	+2.7	75	+60 125	V μA
TEMPERATURE RANGE Specification, T_{MIN} to T_{MAX} Operating Storage Thermal Resistance, θ_{JA}		-40 -55 -65	150	85 125 150	°C °C °C °C

NOTE: (1) Defined as the amount of input voltage, V_{SENSE} , to drive the output to zero.

PIN CONFIGURATION



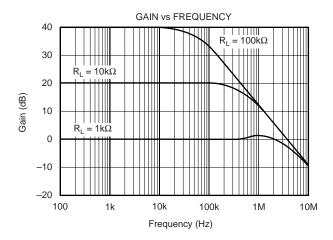
PIN DESCRIPTION

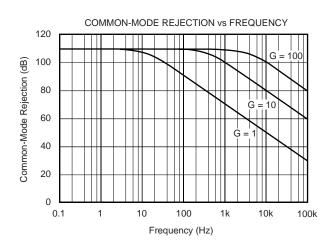
PIN	DESIGNATOR	DESCRIPTION
1	V _{IN} +	Noninverting Input
2	V _{IN}	Inverting Input
3	V_{REF}	Reference Voltage Input
4	GND	Ground
5	R _{os}	Offset Resistor
6	OUT	Output
7	NC	No Connection
8	V+	Supply Voltage
1	l	

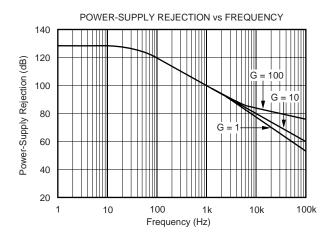


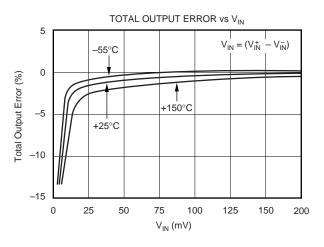
TYPICAL CHARACTERISTICS

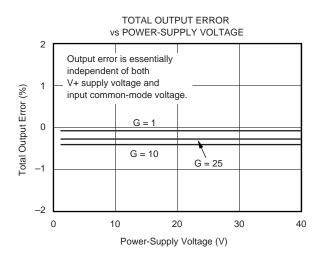
At T_A = +25°C, V+ = 5V, V_{IN}^+ = 12V, R_L = 25k Ω , unless otherwise noted.

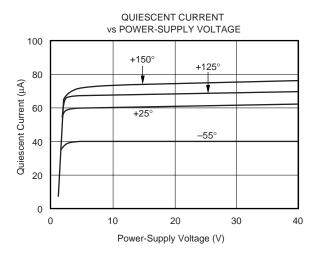








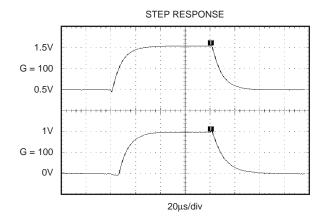


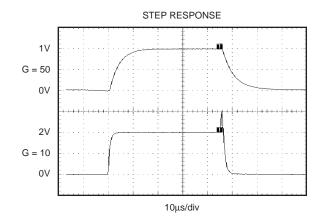




TYPICAL CHARACTERISTICS (Cont.)

At T_A = +25°C, V+ = 5V, V_{1N}^+ = 12V, R_L = 25k Ω , unless otherwise noted.







OPERATION

Figure 1 shows the basic circuit diagram for the INA170. Load current I_S is drawn from supply V_S through shunt resistor R_s . The voltage drop in shunt resistor V_S is forced across R_{G1} by the internal op-amp, causing current to flow into the collector of Q1. External resistor R_L converts the output current to a voltage, V_{OUT} , at the OUT pin.

Without offset, the transfer function for the INA170 is:

$$I_{O} = g_{m} (V_{IN}^{+} - V_{IN}^{-})$$
 (1)

where
$$g_m = 1000 \mu A/V$$
 (2)

In the circuit of Figure 1, the input voltage, $(V_{IN}^+ - V_{IN}^-)$, is equal to $I_S \bullet R_S$ and the output voltage, V_{OUT} , is equal to $I_O \bullet R_L$. The transconductance, g_m , of the INA170 is $1000\mu A/V$. The complete transfer function for the current measurement amplifier in this application is:

$$V_{OUT} = (I_S) (R_S) (1000 \mu A/V) (R_L)$$
 (3)

Applying a positive reference voltage to pin 3 causes a current to flow through R_{OS} , forcing output current I_O to be offset from zero. The transfer function then becomes:

$$V_{OUT} = \left(\frac{V_{REF} \cdot R_L}{R_{OS}}\right) \pm \left(\frac{I_S \cdot R_S \cdot R_L}{1k\Omega}\right)$$
(4)

The maximum differential input voltage for accurate measurements is 0.5V, which produces a 500µA output current. A differential input voltage of up to 2V will not cause damage. Differential measurements (pins 1 and 2) can be

bipolar with a more-positive voltage applied to pin 2. If a more-negative voltage is applied to pin 1, output current I_O will decrease towards zero.

BASIC CONNECTION

Figure 1 shows the basic connection of the INA170. The input pins, V_{IN}^+ and V_{IN}^- , should be connected as closely as possible to the shunt resistor to minimize any resistance in series with the shunt resistance. The output resistor, R_L , is shown connected between pin 6 and ground. Best accuracy is achieved with the output voltage measured directly across R_L . This is especially important in high-current systems where load current could flow in the ground connections, affecting the measurement accuracy.

No power-supply bypass capacitors are required for stability of the INA170. However, applications with noisy or high impedance power supplies may require de-coupling capacitors to reject power-supply noise. Connect bypass capacitors close to the device pins.

POWER SUPPLIES

The input circuitry of the INA170 can accurately measure beyond its power-supply voltage, V+. For example, the V+ power supply can be 5V, while the load power-supply voltage (INA170 input voltage) is up to +60V. However, the output-voltage range of the OUT terminal (pin 6) is limited by the supply.

SELECTING R_S AND R_L

The value chosen for the shunt resistor, R_S , depends on the application and is a compromise between small-signal accuracy and maximum permissible voltage loss in the measurement line. High values of R_S provide better accuracy at lower

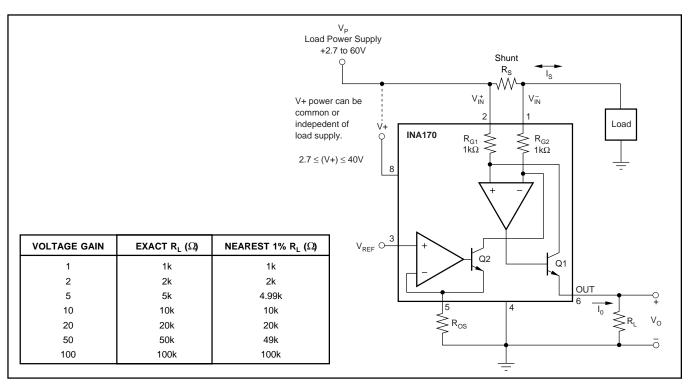


FIGURE 1. Basic Circuit Connections.



currents by minimizing the effects of offset, while low values of $R_{\rm S}$ minimize voltage loss in the supply line. For most applications, best performance is attained with an $R_{\rm S}$ value that provides a full-scale shunt voltage of 50mV to 100mV. Maximum input voltage for accurate measurements is 500mV.

 R_L is chosen to provide the desired full-scale output voltage. The output impedance of the INA170 Out terminal is very high which permits using values of R_L up to $100k\Omega$ with excellent accuracy. The input impedance of any additional circuitry at the output should be much higher than the value of R_L to avoid degrading accuracy.

Some Analog-to-Digital (A/D) converters have input impedances that will significantly affect measurement gain. The input impedance of the A/D converter can be included as part of the effective R_L if its input can be modeled as a resistor to ground. Alternatively, an op-amp can be used to buffer the A/D converter input, as shown in Figure 2. See Figure 1 for recommended values of R_L .

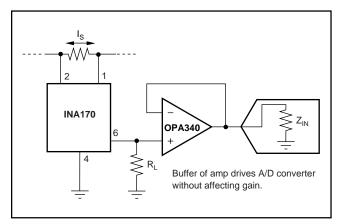


FIGURE 2. Buffering Output to Drive A/D Converter.

OUTPUT VOLTAGE RANGE

The output of the INA170 is a current, which is converted to a voltage by the load resistor, R_L . The output current remains accurate within the *compliance voltage range* of the output circuitry. The shunt voltage and the input common-mode and power supply voltages limit the maximum possible

output swing. The maximum output voltage compliance is limited by the lower of the two equations below:

$$V_{\text{out max}} = (V+) - 0.7V - (V_{\text{IN}}^+ - V_{\text{IN}}^-)$$
 (5)
or
 $V_{\text{out max}} = V_{\text{IN}}^- - 0.5V$ (6)
(whichever is lower)

BANDWIDTH

Measurement bandwidth is affected by the value of the load resistor, R_L . High gain produced by high values of R_L will yield a narrower measurement bandwidth (see Typical Performance Curves). For widest possible bandwidth, keep the capacitive load on the output to a minimum.

If bandwidth limiting (filtering) is desired, a capacitor can be added to the output, as shown in Figure 3. This will not cause instability.

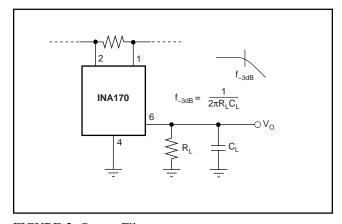


FIGURE 3. Output Filter.

APPLICATIONS

The INA170 is designed for current shunt measurement circuits as shown in Figure 1, but its basic function is useful in a wide range of circuitry. A creative engineer will find many unforeseen uses in measurement and level shifting circuits.

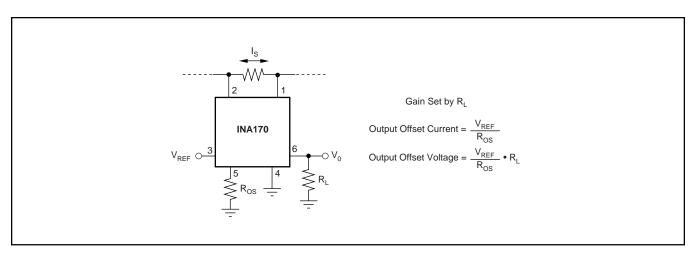


FIGURE 4. Offsetting the Output Voltage.





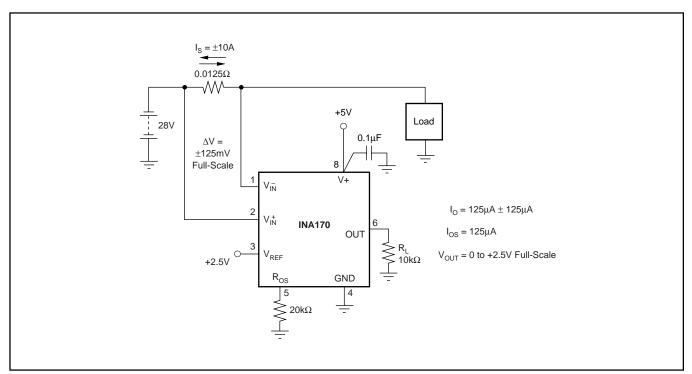


FIGURE 5. Bipolar Current Measurement.

IMPORTANT NOTICE

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgment, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

Customers are responsible for their applications using TI components.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, license, warranty or endorsement thereof.

Reproduction of information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations and notices. Representation or reproduction of this information with alteration voids all warranties provided for an associated TI product or service, is an unfair and deceptive business practice, and TI is not responsible nor liable for any such use.

Resale of TI's products or services with <u>statements different from or beyond the parameters</u> stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service, is an unfair and deceptive business practice, and TI is not responsible nor liable for any such use.

Also see: Standard Terms and Conditions of Sale for Semiconductor Products, www.ti.com/sc/docs/stdterms.htm

Mailing Address:

Texas Instruments Post Office Box 655303 Dallas, Texas 75265